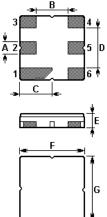


The **ACTR8002/868.35/DCC6C** is a true one-port, surface-acoustic-wave (**SAW**) resonator in a surface-mount ceramic **DCC6C** case. It provides reliable, fundamental-mode, quartz frequency stabilization i.e. in transmitters or local oscillators operating at **868.350** MHz.

2.

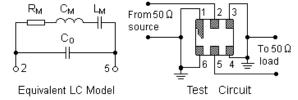
1.Package Dimension (DCC6C)



Pin	Configuration		
2	Input / Output		
5	Output / Input		
1,3,4,6	Ground		

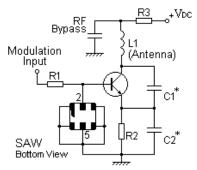
Sign	Data (unit: mm)	Sign	Data (unit: mm)
А	0.6	ш	1.1
В	1.5	F	3.0
С	1.5	G	3.0
D	1.8		

3.Equivalent LC Model and Test Circuit

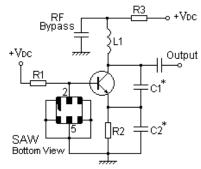


4.Typical Application Circuits

1) Low-Power Transmitter Application



2) Local Oscillator Application



In keeping with our ongoing policy of product evolvement and improvement, the above specification is subject to change without notice.

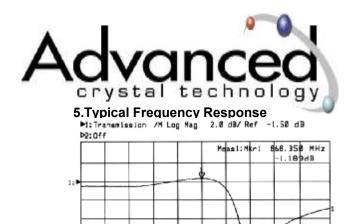
ISO9001: 2000 Registered

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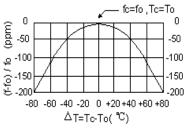
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6.Temperature Characteristics



The curve shown above accounts for resonator contribution only and does not include oscillator temperature characteristics.

7.Performance

Center 868.350 MHz

7-1.Maximum Ratings

Rating	Value	Units
CW RF Power Dissipation	0	dBm
DC Voltage Between Terminals	±30V	VDC
Case Temperature	-40 to +85	°C
Soldering Temperature	+250	°C

Span 1.500 MHz

7-2. Electronic Characteristics							
			_				

	Characteristic	Sym	Minimum	Typical	Maximum	Unit
Centre Frequency (+25 °C)	Absolute Frequency	fc	868.200		868.500	MHz
	Tolerance from 868.350 MHz	Δf_{C}		±150		kHz
Insertion Loss		ΙL		1.5	2.2	dB
Quality Factor	Unloaded Q	Q _U		9,400		
	$50 \ \Omega$ Loaded Q	QL		1,500		
Temperature Stability	Turnover Temperature	T ₀	25		55	°C
	Turnover Frequency	f ₀		fc		kHz
	Frequency Temperature Coefficient	FTC		0.03		ppm/°C ²
Frequency Aging	Absolute Value during the First Year	fA		≤10		ppm/yr
DC Insulation Resis	tance Between Any Two Terminals		1.0			MΩ
RF Equivalent RLC Model	Motional Resistance	Rм		19	29	Ω
	Motional Inductance	L _M		32.7328		μН
	Motional Capacitance	См		1.0273		fF
	Shunt Static Capacitance	C 0	2.1	2.4	2.7	pF

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i CAUTION: Electrostatic Sensitive Device. Observe precautions for handling!

- 1. The centre frequency, f_c , is measured at the minimum IL point with the resonator in the 50 Ω test system.
- 2. Unless noted otherwise, case temperature $T_c = +25^{\circ}C \pm 2^{\circ}C$.
- Frequency aging is the change in f_c with time and is specified at +65°C or less. Aging may exceed the specification for prolonged temperatures above +65°C. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
- 4. Turnover temperature, \overline{T}_0 , is the temperature of maximum (or turnover) frequency, f_0 . The nominal frequency at any case temperature, T_c , may be calculated from: $f = f_0 [1 FTC (T_0 T_c)^2]$.
- 5. This equivalent RLC model approximates resonator performance near the resonant frequency and is provided for reference only. The capacitance C₀ is the measured static (non-motional) capacitance between the two terminals. The measurement includes case parasitic capacitance.
- 6. Derived mathematically from one or more of the following directly measured parameters: f_C , IL, 3 dB bandwidth, f_C versus T_C , and C_0 .
- 7. The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
- 8. Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
- 9. Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.

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